
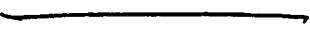
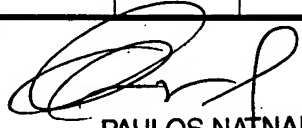


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/804,406	LEE, TAE WON	
	Examiner	Art Unit	
	Paulos M. Natnael	2622	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS	SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
348	180				455	277.2				
INTERNATIONAL CLASSIFICATION										
H	0	4	N	5/00						
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				/						
				/						
				/						

 (Assistant Examiner) (Date)		 <b>PAULOS NATNAEL</b> <b>PRIMARY PATENT EXAMINER</b> (Primary Examiner) (Date)		Total Claims Allowed: 33  O.G. Print Claim(s) 1 O.G. Print Fig. 2	
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<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant						<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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